

<b>Notice of References Cited</b>		Application/Control No. 10/728,304	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
		Examiner Tung X. Nguyen	Art Unit 2829	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,577,490	06-2003	Ogawa et al.	361/306.1
	B	US-6,756,663	06-2004	Shiraishi et al.	257/686
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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